

# Low-Voltage Dual SPDT Analog Switch UM3257 DFN12 3.0×1.6

#### **General Description**

The UM3257 is dual SPDT analog switch fabricated with silicon gate CMOS technology. It achieves very low propagation delay and  $R_{DS(ON)}$  resistances while maintaining CMOS low power dissipation. These make it ideal for portable and battery power applications.

The switch conducts signals within power rails equally well in both directions when on, and blocks up to the power supply level when off. Break-before-make is guaranteed.

The select pin has over-voltage protection that allows voltages above  $V_{CC}$ , up to 6.5V to be present on the pin without damage or disruption of operation of the part, regardless of the operating voltage.

The UM3257 can maintain low power consumption for rail-to-rail signaling as long as the control signal input is held at a level that is greater than  $V_{\rm IH}$  minimum and less than  $V_{\rm IL}$  maximum by improving the control circuitry input buffer. so the part can be used in mixed voltage rail environments, especially services the mobile handset applications very well allowing for the direct interface with baseband processor general purpose I/Os, and it is no longer necessary to have the control input equal to  $V_{\rm CC}$  to maintain low power consumption

The UM3257 is in a 12-pin, ROHS compliant, DFN12 package. It measures 3.0×1.6mm. The leads are spaced at a pitch of 0.5mm and are finished with lead free Ni-Pd. The small package makes it ideal for use in portable electronics such as cell phones, digital cameras and PDAs.

#### **Applications**

- Sample-and-Hold Circuits
- Battery-Powered Equipment
- Audio and Video Signal Routing
- Communication Circuits

#### **Features**

- Lower I<sub>CC</sub> when the S Input is within the Required V<sub>IH</sub> and V<sub>IL</sub> Bounds
- Low ON-State Resistance ( $10\Omega$ )
- Control Inputs are 5V Tolerant
- Low Charge Injection
- Excellent ON-State Resistance Matching
- Low Total Harmonic Distortion (THD)
- 1.65V to 5.5V Single-Supply Operation
- ESD Performance: Human Body Model>2kV Machine Model>200V
- DFN12 Package
- Pb-Free Package

#### **Pin Configurations**

# So 1 1 12 0B1 VCC 2 11 GND AD 3 10 0B0 S1 4 9 1B1 VCC 5 8 GND A1 6 7 1B0

#### **Top View**

3257:XX

XX: Week Code UM3257 DFN12 3.0×1.6



#### **Ordering Information**

Part Number	Packaging Type	Marking Code	Shipping Qty
UM3257	DFN12 3.0×1.6	3257	3000pcs/7 Inch Tape & Reel

#### **Function Table**

Select Input	Function
L	B0 Connected to A
Н	B1 Connected to A

### **Absolute Maximum Ratings**

Symbol	Parameter	Limit	Unit
$V_{CC}$	Supply Voltage	-0.5 to +6.5	
$V_{IS}$	DC Switch Input Voltage (Note 1)	$-0.5$ to $(V_{CC}+0.5)$	V
$ m V_{IN}$	DC IN Voltage (Note 1)	-0.5 to +6.5	
$I_{IK}$	DC Input Diode Current @ V <sub>IN</sub> <0V	-50	
$I_{OUT}$	I <sub>OUT</sub> DC Output Current		mA
$I_{CC}/I_{GND}$	DC V <sub>CC</sub> or Ground Current	+100	
$T_{\mathrm{J}}$	Junction Temperature Under Bias	+150	
$T_{STG}$	Storage Temperature	-65 to +150	°C
$T_{ m L}$	Junction Lead Temperature (Soldering, 10 Seconds)	260	
$ heta_{ m JA}$	Thermal Resistance	350	°C/W
$P_{\mathrm{D}}$	Power Dissipation @ +85°C	180	mW

Note 1: The input and output negative voltage ratings may be exceeded if the input and output diode current ratings are observed.

# **Recommended Ratings (Note2)**

Symbol	Parameter	Limit	Unit
$V_{CC}$	Supply Voltage Operating	1.65 to 5.5	V
$V_{IS}$	Switch Input Voltage	0 to V <sub>CC</sub>	
$ m V_{IN}$	Select Input Voltage	$0$ to $V_{CC}$	
$V_{OUT}$	Output Voltage	0 to V <sub>CC</sub>	
$T_{A}$	Operating Temperature	-55 to +125	°C
$t_r, t_f$	Input Rise and Fall Time Control Input $V_{CC}$ =2.3V to 3.6V Control Input $V_{CC}$ =4.5V to 5.5V	0 to 10 0 to 5.0	ns/V

Note 2: Select input must be held HIGH or LOW, it must not float.



#### **Electrical Characteristics**

Ch -1	Parameter	Test Conditions	V <sub>CC</sub> (V)	Temp	Limits (-40°C to 85°C)			TIm:t		
Symbol		Test Conditions			Min	Тур	Max	Unit		
DC Electrical Characteristics										
	Analog Signal Range		$V_{cc}$	Full	0		$V_{cc}$	V		
$I_{IN}$	Input Leakage Current	0≤V <sub>IN</sub> ≤5.5V	0 to 5.5	Room Full		±0.05	±0.1 ±1	μΑ		
$I_{OFF}$	OFF State Leakage Current	0≤A, B≤V <sub>CC</sub>	1.65 to 5.5	Room Full		±0.05	±0.1 ±1	μΑ		
$V_{IH}$	Input High Voltage		1.65 to 1.95 2.3 to 5.5	Full	0.75Vcc 0.7Vcc			V		
$V_{\rm IL}$	Input Low Voltage		1.65 to 1.95 2.3 to 5.5	Full			0.25Vcc 0.3Vcc	V		
$I_{CC}$	Quiescent Supply Current	$V_{IN}=V_{CC}$ or GND $I_O=0$	5.5	Room Full			1.0 10	μΑ		
		V <sub>IN</sub> =0V, I <sub>O</sub> =30mA V <sub>IN</sub> =2.4V, I <sub>O</sub> =-30mA V <sub>IN</sub> =4.5V, I <sub>O</sub> =-30mA	4.5	Full		3.0 5.0 7.0	6.0 8.0 13	Ω		
$R_{ON}$	On-Resistance (Note3)	V <sub>IN</sub> =0V, I <sub>O</sub> =24mA V <sub>IN</sub> =3V, I <sub>O</sub> =-24mA	3.0	Full		4.0 10	8.0 19			
	, ,	V <sub>IN</sub> =0V, I <sub>O</sub> =8mA V <sub>IN</sub> =2.3V, I <sub>O</sub> =-8mA	2.3	Full		5.0 13	9.0 24			
		V <sub>IN</sub> =0V, I <sub>O</sub> =4mA V <sub>IN</sub> =1.65V, I <sub>O</sub> =-4mA	1.65	Full		6.5 17	12 39			
		$I_A$ =-30mA , $0 \le V_{Bn} \le V_{CC}$	4.5	Full			25			
R <sub>RANGE</sub>	On Resistance Over	I <sub>A</sub> =-24mA, 0≤V <sub>Bn</sub> ≤Vcc	3.0	Full			50	Ω		
KRANGE	Signal Range (Note3, 7)	$I_A$ =-8mA, $0 \le V_{Bn} \le Vcc$	2.3	Full			100			
		$I_A$ =-4mA, $0 \le V_{Bn} \le Vcc$	1.65	Full			300			
		$I_A = -30 \text{mA}, V_{Bn} = 3.15 \text{V}$	4.5	Room		0.15				
$\Delta R_{ m ON}$	On Resistance Match Between Channels	$I_A$ =-24mA, $V_{Bn}$ = 2.1V	3.0	Room		0.2		Ω		
ΔKON	(Note3, 4, 5)	$I_A = -8 \text{ mA}, V_{Bn} = 1.6 \text{ V}$	2.3	Room		0.5				
		$I_A$ =-4mA, $V_{Bn}$ = 1.15V	1.65	Room		0.5				
	On Resistance Flatness (Note3, 4, 6)	I <sub>A</sub> =-30mA, 0≤V <sub>Bn</sub> ≤Vcc	5.0	Room		5.0				
D		I <sub>A</sub> =-24mA, 0≤V <sub>Bn</sub> ≤Vcc	3.3	Room		10		Ω		
R <sub>FLAT</sub>		$I_A$ =-8mA, $0 \le V_{Bn} \le V_{CC}$	2.5	Room		24		22		
		$I_A$ =-4mA, $0 \le V_{Bn} \le V_{CC}$	1.8	Room		110				

- Note 3: Measured by the voltage drop between A and B pins at the indicated current through the switch. On Resistance is determined by the lower of the voltages on the two (A or B Ports).
- Note 4: Parameter is characterized but not tested in production.
- Note 5:  $\Delta R_{ON} = |R_{ON (A00Bn)} R_{ON (A11Bn)}|$  measured at identical  $V_{CC}$ , temperature and voltage levels.
- Note 6: Flatness is defined as the difference between the maximum and minimum value of On Resistance over the specified range of conditions.
- Note 7: Guaranteed by design.



#### **Electrical Characteristics (Continued)**

6 1 1	D	TF 4 C 1141	N. OD	T.	Limits (-40°C to 85°C)			<b>T</b> I *4		
Symbol	Parameter	Test Conditions	$\mathbf{V}_{\mathbf{CC}}\left(\mathbf{V}\right)$	Temp	Min	Тур	Max	Unit		
AC Electric	AC Electrical Characteristics									
t <sub>PHL</sub> t <sub>PLH</sub>	Propagation Delay Bus to Bus (Note 9)	V <sub>I</sub> =OPEN	1.65 to 1.95 2.3 to 2.7 3.0 to 3.6 4.5 to 5.5	Room		1.2 0.8 0.3		ns		
t <sub>PZL</sub> t <sub>PZH</sub>	Output Enable Time Turn On Time (A to Bn)	$V_{i}$ =2× $V_{CC}$ for $t_{PZL}$ $V_{i}$ =0 $V$ for $t_{PZH}$	1.65 to 1.95 2.3 to 2.7 3.0 to 3.6 4.5 to 5.5	Full	7.0 3.5 2.5 1.7		32 14 7.6 5.7	ns		
t <sub>PLZ</sub> t <sub>PHZ</sub>	Output Disable Time Turn Off Time (A Port to B Port)	$\begin{array}{c} V_I \!\!=\!\! 2 \!\!\times\! V_{CC} \text{ for } t_{PLZ} \\ V_I \!\!=\!\! 0 V \text{ for } t_{PHZ} \end{array}$	1.65 to 1.95 2.3 to 2.7 3.0 to 3.6 4.5 to 5.5	Full	3.0 2.0 1.5 0.8		28 15 11 8	ns		
t <sub>BBM</sub>	Break Before Make Time (Note 8)	$R_L$ =50 $\Omega$ , $C_L$ =35 $pF$	1.65 to 1.95 2.3 to 2.7 3.0 to 3.6 4.5 to 5.5	Full	0.5 0.5 0.5 0.5			ns		
Q <sub>INJ</sub>	Charge Injection (Note 8)	$C_L$ =0.1nF, $V_{GEN}$ =0V, $R_{GEN}$ =0 $\Omega$	5.0 3.3	Room		7.0 3.0		pC		
${ m O}_{IRR}$	Off Isolation (Note 10)	$R_L$ =50 $\Omega$ , f=10 MHz	1.65 to 5.5	Room		-55		dB		
Xtalk	Crosstalk	$R_L$ =50 $\Omega$ , f=10 MHz	1.65 to 5.5	Room		-54		dB		
BW	-3dB Bandwidth	$R_L=50\Omega$	2.5 to 5.5	Room		250		MHz		
THD	Total Harmonic Distortion (Note8)	$R_L$ =600 $\Omega$ , 0.5 $V_{P-P}$ , f=600Hz to 20kHz	2.5 5.0	Room		0.014 0.004		%		
Capacitance										
$C_{\text{IN}}$	IN Pin Input Capacitance (Note11)	V <sub>CC</sub> =0V				2.3		pF		
C <sub>IO-B</sub>	B Port Off Capacitance (Note11)	V <sub>CC</sub> =5.0V				6.5		pF		
C <sub>IOA-ON</sub>	A Port Capacitance when Switch is Enabled (Notel1)	V <sub>CC</sub> =5.0V				18.5		pF		

Note 8: Guaranteed by design.

Note 9: This parameter is guaranteed by design but not tested. The bus switch contributes no propagation delay other than the RC delay of the On Resistance of the switch and the 35 pF load capacitance, when driven by an ideal voltage source (zero output impedance).

Note 10: Off Isolation=20log<sub>10</sub> [V<sub>A</sub>/V<sub>Bn</sub>].

Note 11: T<sub>A</sub>=+25°C, f=1MHz, Capacitance is characterized but not tested in production.



#### **Test Circuits/Timing Diagrams**

NOTE: Input driven by  $50~\Omega$  source terminated in  $50~\Omega$  NOTE:  $C_L$  includes load and stray capacitance NOTE: Input PRR = 1.0 MHz;  $t_W$  = 500 ns

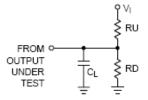


Figure 1 . AC Test Circuit

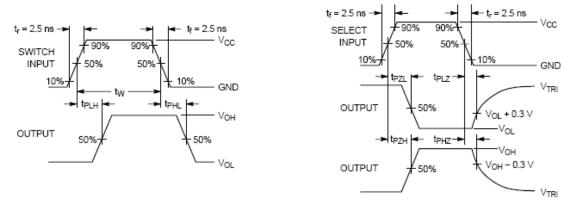


Figure 2. AC Waveforms



Figure 3. Break Before Make Interval Timing



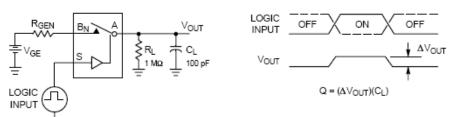
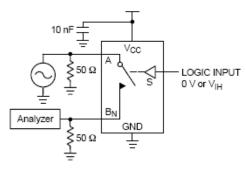
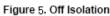


Figure 4. Charge Injection Test





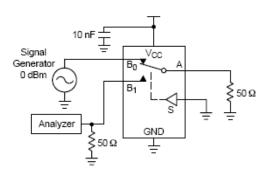


Figure 6. Crosstalk

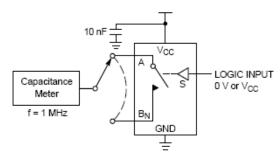


Figure 7. Channel Off Capacitance

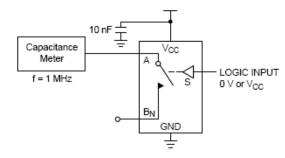


Figure 8. Channel On Capacitance

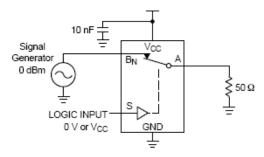
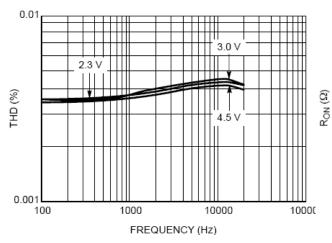


Figure 9 . Bandwidth

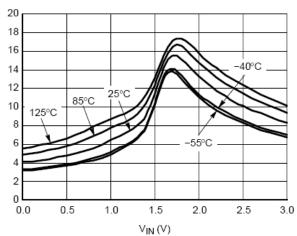


#### **Typical Operating Characteristics**

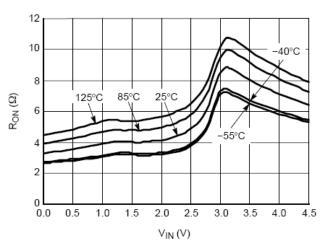
#### **Total Harmonic Distortion vs. Frequency**



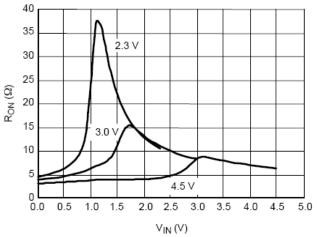
 $R_{ON}$  vs.  $V_{IN}$  vs. Temperature @  $V_{CC}\!\!=\!\!3.0V$ 



 $R_{ON}$  vs.  $V_{IN}$  vs. Temperature @  $V_{CC}$ =4.5V

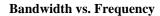


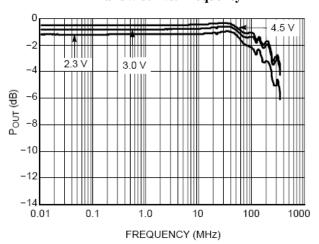
On-Resistance vs. Input Voltage



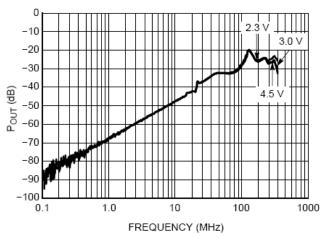


# **Typical Operating Characteristics (Continued)**

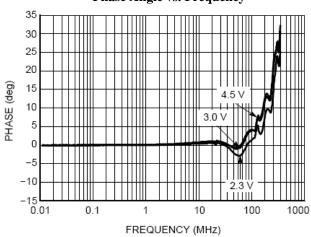




#### Off-Isolation vs. Frequency



#### Phase Angle vs. Frequency

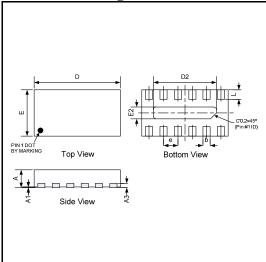




# **Package Information**

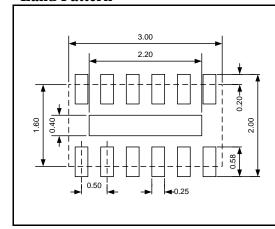
#### UM3257 DFN12 3.0×1.6

**Outline Drawing** 



DIMENSIONS								
Crombal	MILLIMETERS			INCHES				
Symbol	Min	Тур	Max	Min	Тур	Max		
A	0.50	0.55	0.605	0.020	0.022	0.024		
A1	0.00	-	0.05	0.000	1	0.002		
A3	0.15REF			0.006REF				
b	0.20	0.25	0.30	0.008	0.010	0.012		
D	2.95	3.00	3.075	0.116	0.118	0.121		
D2	2.10	2.20	2.30	0.083	0.087	0.091		
Е	1.55	1.60	1.675	0.061	0.063	0.066		
E2	0.25	-	0.50	0.010	-	0.020		
e	0.50TYP			0.020TYP				
L	0.23	-	0.38	0.009	-	0.015		

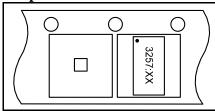
#### **Land Pattern**



#### NOTES:

- 1. Compound dimension: 3.00×1.60;
- 2. Unit: mm;
- 3. General tolerance  $\pm 0.05$ mm unless other- wise specified;
- 4. The layout is just for reference.

**Tape and Reel Orientation** 





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